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Application/Control No.	Applicant(s)/Patent und Reexamination	er
10/667,528	TANI, AKIRA	
Examiner	Art Unit	
Michael P. Ferguson	3679	

	SEARCHED		
Class	Subclass	Date	Examiner
403	292,294, 296,305	6/15/2005	MPF
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
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